## Supplementary Materials: Fluorescence Enhancement Using Bimetal Surface Plasmon-Coupled Emission from 5-Carboxyfluorescein (FAM)

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**Figure S1.** (a) and (b) represent reflectance curves as a function of incident angle, for a single layer of Au and Ag of various thicknesses, respectively. (c) and (d) represent enhancement of the electric field intensity versus distance from the metallic surface in a liquid region at the excitation wavelength ( $\lambda_{ex}$  = 470 nm).

## **Calculation of Electric Field Intensity Enhancement**

We computed the reflectance of light in a Kretschmann-Raether surface plasmon resonance (SPR) configuration, using an optical transfer matrix formula, for a multilayer stack. For a multilayer stack of *N* layers, labeled as 0 (prism) to *N* (liquid with fluorophores), we assumed the transverse magnetic polarization of incident light and thus obtained the tangential components of the electric (*E*<sub>*a*</sub>) and the magnetic (*B*<sub>*a*</sub>) fields at the boundary between the layers *N*–1 and *N*, as follows:

$$\begin{bmatrix} E_a \\ B_a \end{bmatrix} = \prod_{i=1}^{N} \begin{bmatrix} \cos \delta_i & \frac{i \sin \delta_i}{\gamma_i} \\ i \gamma_i \sin \delta_i & \cos \delta_i \end{bmatrix} \begin{bmatrix} E_N \\ B_N \end{bmatrix}$$
(1)

Here,

$$\delta_i = \left(\frac{2\pi}{\lambda}\right) n_i d_i \cos \theta_i \tag{2}$$

$$\gamma_i = \frac{n_i \sqrt{\varepsilon_0 \mu_0}}{\cos \theta_i} \tag{3}$$

Here  $\delta_i$  is the optical phase introduced by a single traversal of the field across the *i*<sup>th</sup> layer. We denoted  $n_i$  and  $d_i$  as the refractive index and the thickness of the *i*<sup>th</sup> layer, respectively.  $\theta_i$  is the incident angle of light to the *i*<sup>th</sup> layer.  $\varepsilon_0$  and  $\mu_0$  are the permittivity and permeability of free space, respectively. Using  $\sum_{i=1}^{N} M_i = m$ , where  $M_i$  is the individual transfer matrix, the reflection coefficient *r* for transverse magnetic (TM)-polarized light is then expressed as:

$$r = \frac{\gamma_N m_{11} + \gamma_0 \gamma_N m_{12} - m_{21} - \gamma_0 m_{22}}{\gamma_N m_{11} + \gamma_0 \gamma_N m_{12} + m_{21} + \gamma_0 m_{22}}$$
(4)

$$t = \frac{2\gamma_0(\frac{n_N}{n_0})}{\gamma_N m_{11} + \gamma_0 \gamma_N m_{12} + m_{21} + \gamma_0 m_{22}}$$
(5)

Then, the field enhancement is given by  $\frac{I_2}{I_1} = \sqrt{\frac{\varepsilon_{r_2}}{\varepsilon_{r_0}}} |t|^2$ .